



**Jet Propulsion Laboratory**  
California Institute of Technology

# Reliability of GaSb-based lasers for space applications

Mathieu Fradet<sup>1</sup>, Ryan Briggs<sup>1</sup>, Clifford Frez<sup>1</sup>, Siamak Forouhar<sup>1</sup>, James Gupta<sup>2</sup> and Chris Webster<sup>1</sup>

<sup>1</sup>Jet Propulsion Laboratory, California Institute of Technology; <sup>2</sup>National Research Council of Canada

# Outline

- Space application
- Importance of GaSb-based semiconductor lasers
- GaSb-based LC-DFB laser fabrication
- Reliability measurements
- Failures
- Packaging and environmental testing
- Conclusion

# Space application

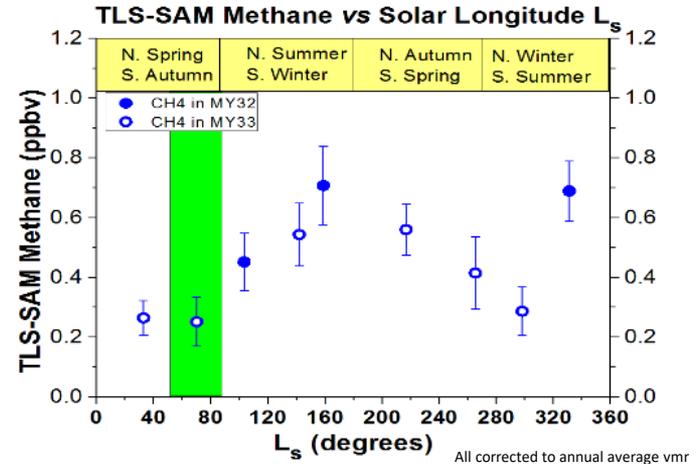
## Tunable Laser Spectrometer (TLS) on Mars rover Curiosity



Principal investigator: Dr. Chris Webster, JPL

TLS is a two-channel tunable laser spectrometer using a 2.78  $\mu\text{m}$  diode laser and a 3.27  $\mu\text{m}$  Interband Cascade (IC) laser developed by Rui Q. Yang. These lasers operated at sub-ambient temperatures and required multi-stage coolers.

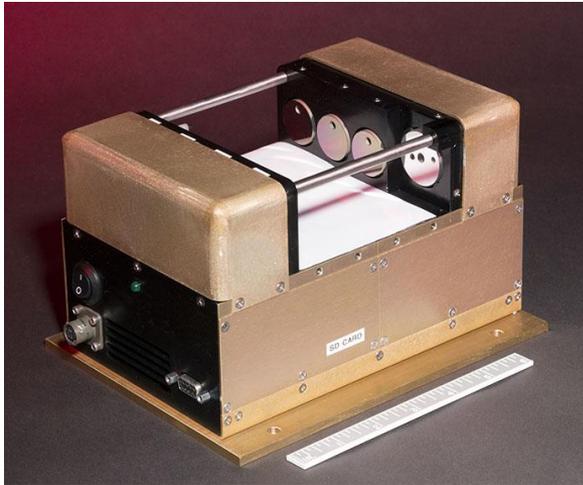
In the Mars atmosphere, TLS measures  $\text{CH}_4$ ,  $\text{CO}_2$ ,  $\text{H}_2\text{O}$  and the isotopic ratios  $^{13}\text{C}/^{12}\text{C}$ ,  $^{18}\text{O}/^{17}\text{O}/^{16}\text{O}$ , and D/H



Detection of atmospheric methane at low background levels ( $\sim 0.5$  ppbv) that show a seasonal pattern, and in episodic releases (7 ppbv) show Mars is active - *Webster et al., 2015*

# Space application

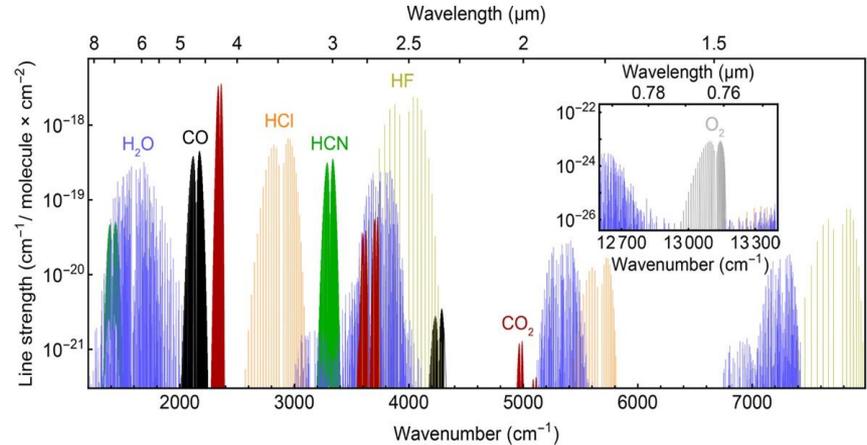
## Combustion Product Monitoring (CPM) Instrument



Instrument manager: Dr. Ryan M. Briggs, JPL

CPM is a **six-channel tunable laser** that monitors gas concentrations that are representative of combustion product that would be expected from an on-orbit fire.

Developed for use in the **Saffire experiment inside the Cygnus re-supply vehicle.**



The gases measured are: O<sub>2</sub>, CO<sub>2</sub>, CO, HF, HCl, and HCN

Concentration range are:

**HF, HCl, HCN: 2 - 50 ppmv**

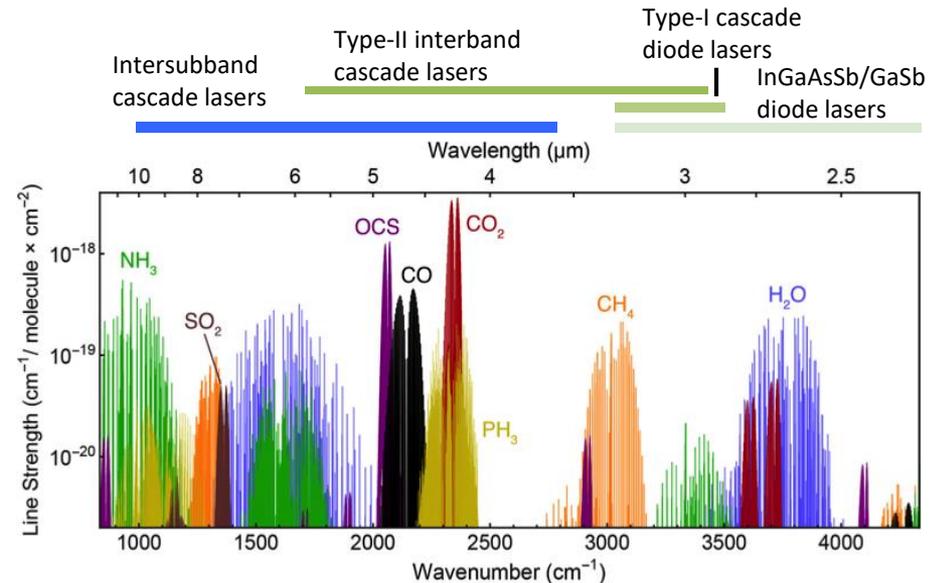
**CO: 5 - 1,000 ppmv**

**CO<sub>2</sub>: 300 - 30,000 ppmv**

**O<sub>2</sub>: 14 - 50%**

# Fabrication challenges for mid-IR semiconductor lasers

- **Strong fundamental rovibrational modes of target compounds occur in the mid-infrared regime**
  - Absorption measurements require corresponding mid-infrared sources and detectors
- **Lasers in the 2.4-3.6  $\mu\text{m}$  wavelength range can only be addressed by GaSb-based material systems**
- Complex bandgap engineering is required
- GaSb epitaxial growth for semiconductor lasers isn't available at commercial foundries
  - Suppliers are universities or national laboratories
- GaSb material systems not compatible with standard DFB laser fabrication
- Requires unique laterally-coupled feedback gratings
- **Fabrication of reliable sources remains a challenge**



# GaSb-based laser

GaSb-based semiconductor lasers can target numerous gas

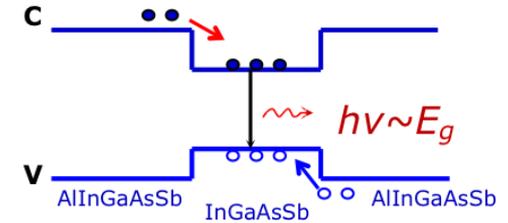
## • GaSb-based type-I diode lasers

- InGaAsSb/AlInGaAsSb QWs
- Viability proven in the 2- to 3.3- $\mu\text{m}$  regime.
- Both professor Gregory Belenky's group from SUNY at Stony Brook and James Gupta's group from National Research Council of Canada have developed diodes with emission above 3- $\mu\text{m}$ .
- Driven by mature, low-power consumption, and reliable **3.27  $\mu\text{m}$  source for methane detection**

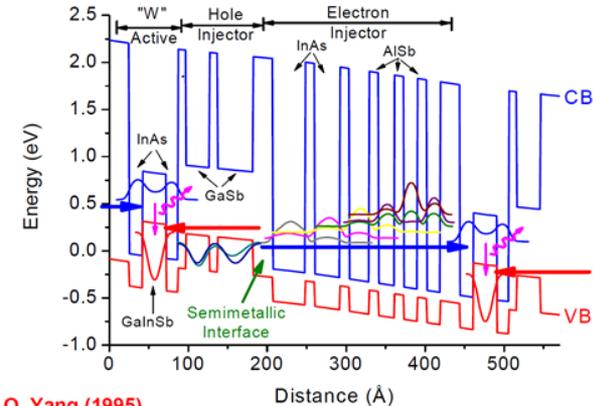
## • GaSb-based type-II interband cascade lasers

- Developed by Rui Q. Yang
- Multiple quantum well, hole and electron injector stages to emit multiple photons.
- Jerry Meyer's group at Naval Research Lab (NRL) and nanoplus GMBH have developed single-mode ICLs near and below 3- $\mu\text{m}$ .
- Driven by low current threshold, high optical output power at **3.57  $\mu\text{m}$  for HCl detection**

### Diode laser structure

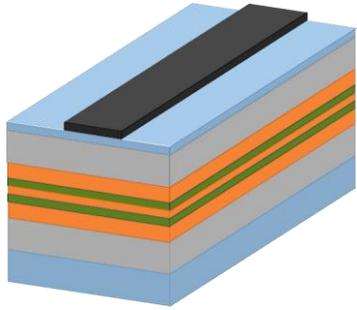


### IC laser structure

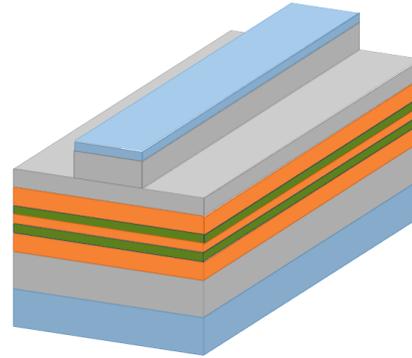


R. Q. Yang (1995)

# GaSb-based LC-DFB laser fabrication

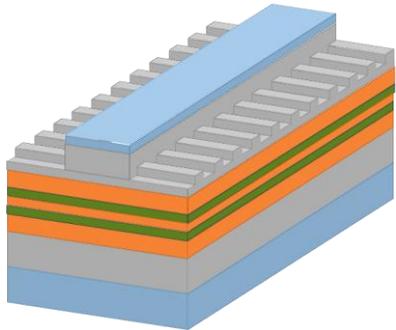
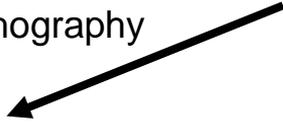


Define 4- $\mu\text{m}$  wide ridge waveguide with optical lithography

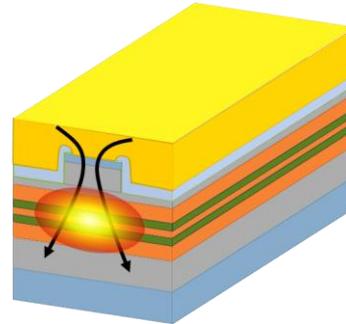


Ridge waveguide etched  $\sim 2\text{-}\mu\text{m}$  deep using a  $\text{BCl}_3/\text{Cl}_2$  plasma

E-beam lithography



Etching of second order Bragg gratings

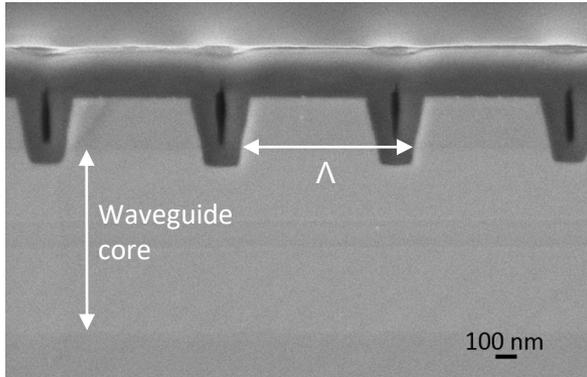
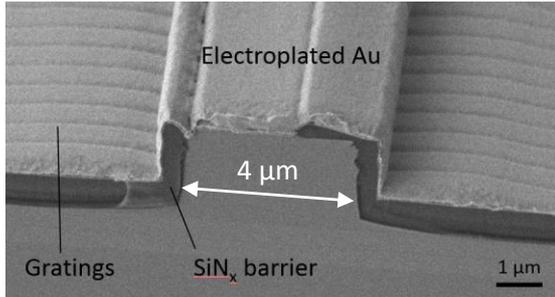


Add steps for double-ridge structure

Deposition of  $\text{SiN}_x$   $\sim 400\text{-nm}$  followed by  $\sim 4\text{-}\mu\text{m}$  thick electroplated Au top contact

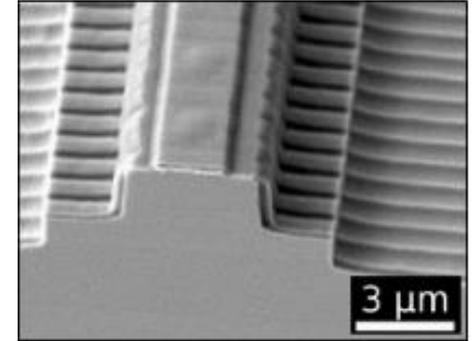
# GaSb-based LC-DFB laser fabrication

## LC-DFB diode laser



- Fabrication of 4- $\mu\text{m}$  wide ridges, grating pitch  $\Lambda = m \cdot \lambda / n_{\text{eff}}$  ( $m=1,2,3,\dots$ ), duty cycle 30%.
- Laterally-coupled distributed feedback gratings were developed to avoid etching through the active structure due to reliability concerns.
- Gratings do not penetrate into the top barrier close to the ridges, but do so far from it.

## LC-DFB IC laser



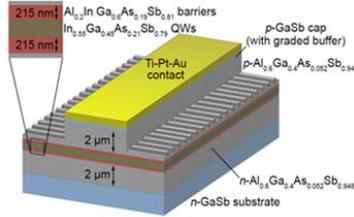
DFB laser architecture for IC lasers used a double-ridge design due to current spreading in the active region.

It reduces threshold current by a factor 6.

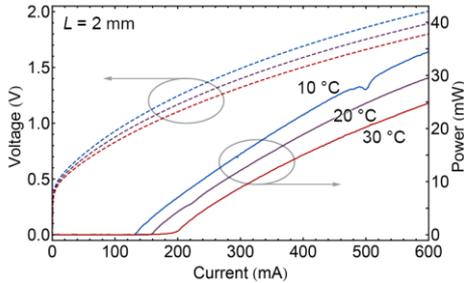
Hybrid configuration where the active region is etched all the way through, but this is done far from where the optical mode is generated

# Diode performance

## 2.65 $\mu\text{m}$

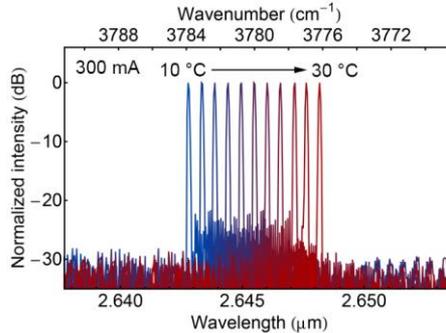


Seven 6.6 nm InGaAsSb QWs separated by 20 nm quinary AlInGaAsSb barriers and a 215 nm thick SCH layer between the upper and lower cladding layers and the QWs.

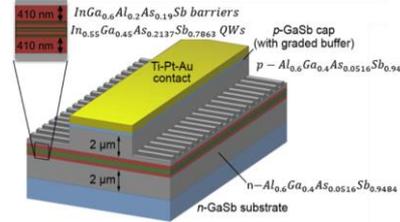


Briggs *et al.*, Optics Express 21 (2013)

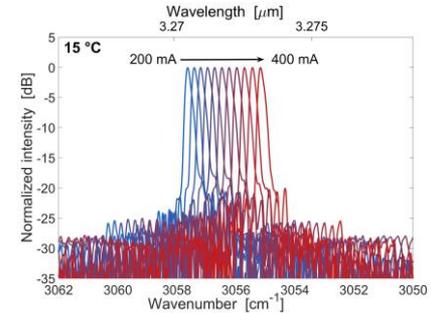
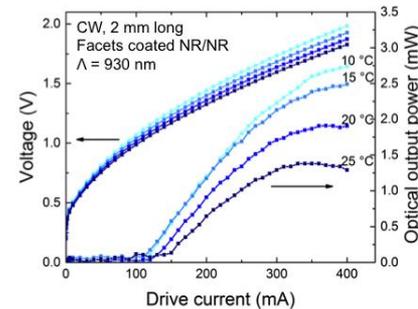
Current threshold 160 mA at 20 °C, and a tuning rate of 0.27 nm/°C  
The optical spectra measured with a FTIR shows a side-mode suppression ratio (SMRS) over 25 dB



## 3.27 $\mu\text{m}$



Three 17 nm InGaAsSb QWs separated by 30 nm quinary AlInGaAsSb barriers and a 410 nm thick SCH layer between the upper and lower cladding layers and the QWs.

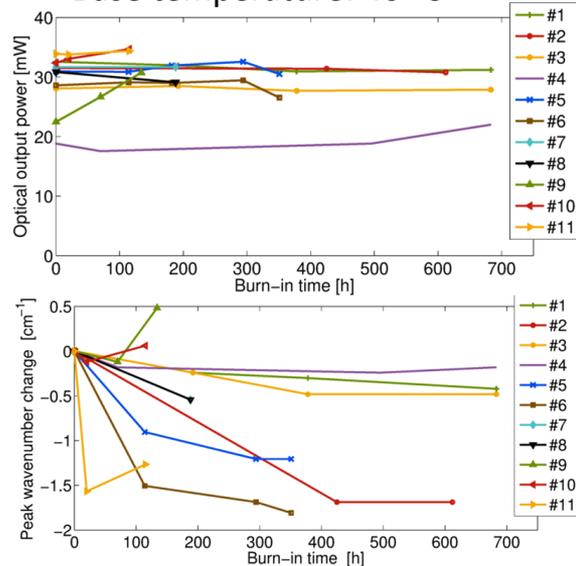


Current threshold 110 mA at 20 °C, and a tuning rate of 0.33 nm/°C  
The optical spectra measured with a FTIR shows a side-mode suppression ratio (SMRS) over 25 dB

# Diode performance

2.65  $\mu\text{m}$

Constant current mode: 500 mA  
Base temperature: 40 °C

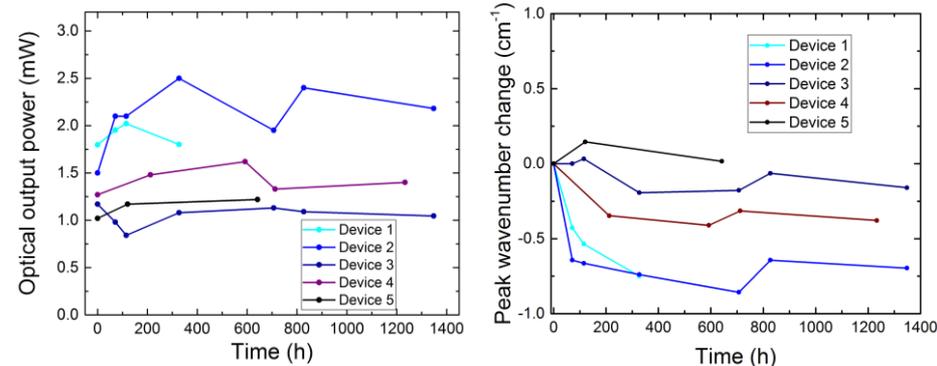


- **Peak wavenumber stabilizes after 100-200 hours**
- The change in peak wavenumber is less than 2  $\text{cm}^{-1}$
- Measured red-shift in wavelength emission
- Resistance increased of 3 mOhm across the laser

1/29/2018

3.27  $\mu\text{m}$

Constant current mode: 350 mA  
Base temperature: 30 °C



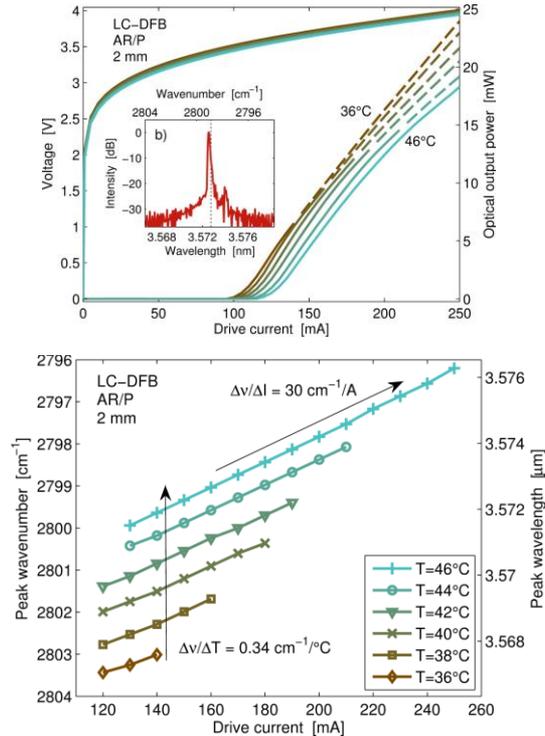
- **Peak wavenumber stabilizes after 100-300 hours**
- The change in peak wavenumber is less than 1  $\text{cm}^{-1}$
- Measured red-shift in wavelength emission
- Resistance increased of 17 mOhm across the laser

SPIE Photonics West

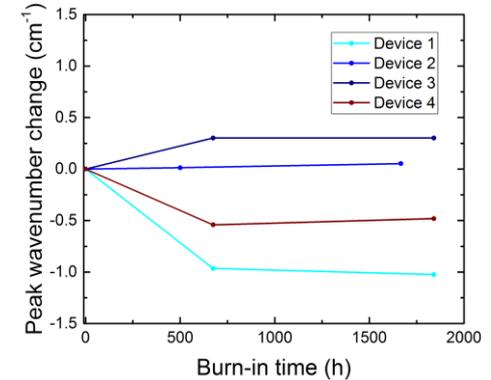
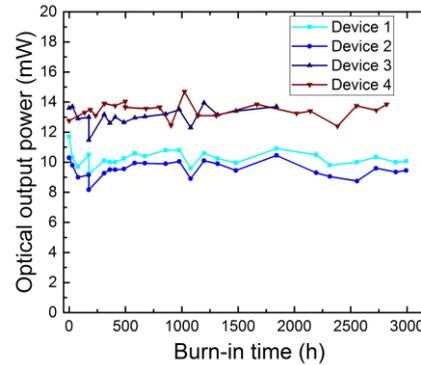
jpl.nasa.gov

# IC laser emitting near 3.57 $\mu\text{m}$ performance

Constant current mode: 200 mA  
Base temperature: 40  $^{\circ}\text{C}$



Forouhar *et al.*, Appl. Phys. Lett. 105 (2014)

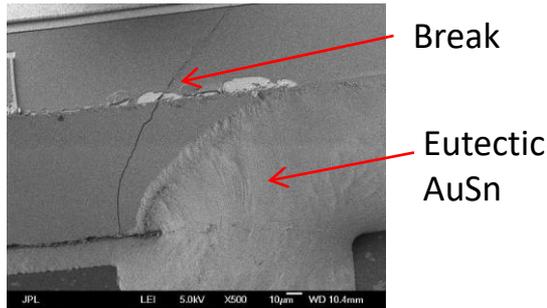


Current threshold 100 mA at 36  $^{\circ}\text{C}$ , and a tuning rate of 0.43 nm/ $^{\circ}\text{C}$   
The optical spectra measured with a FTIR shows a side-mode suppression ratio (SMRS) over 25 dB

- **Peak wavenumber stabilizes after 100-300 hours**
- The change in peak wavenumber is less than 1  $\text{cm}^{-1}$
- Measured red-shift in wavelength emission
- Resistance decreased of 6 mOhm across the laser

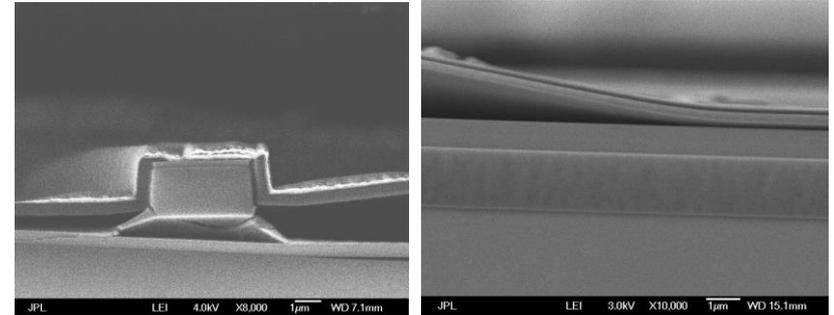
# Failures

## Stress due to CTE mismatch and poor solder flow



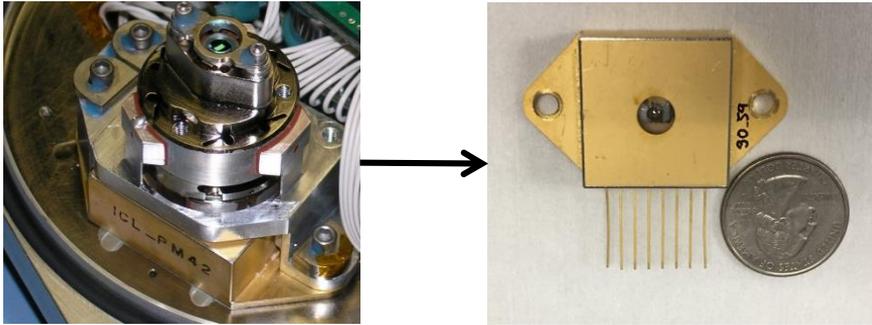
- CTE mismatch between submount and laser due to requirement in submount material.
- Poor solder flow, and the use of eutectic AuSn (hard solder) caused the device to break due to the CT mismatch between the laser and submount.
- Problem was solved using indium solder (soft solder).

## Device oxidation



- High aluminum content in cladding layers.
- Great laser performances.
- Reliability issues due to rapid oxidation of high aluminum-content layers causing delamination.
- Reduced aluminum content in cladding layers solved the oxidation issues.

# Packaging of 3.27 $\mu\text{m}$ laser

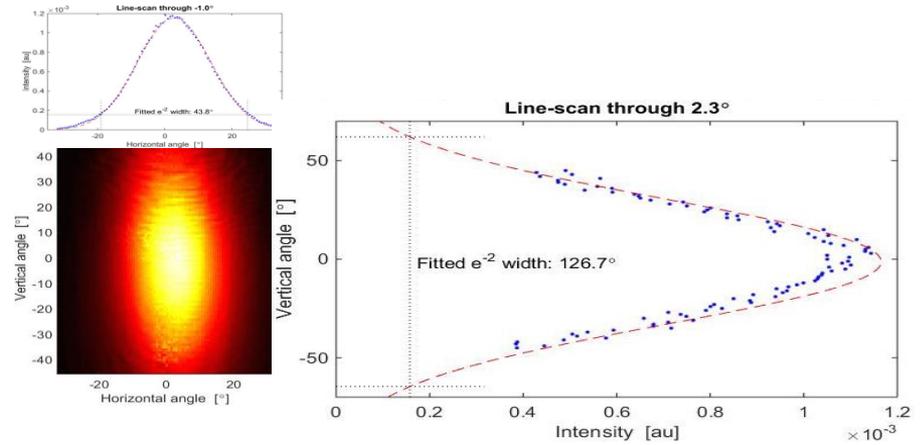


Effort in reducing size and alignment complexity, replaced 3 lens collimator with a single lens inside a package with same form factor through a collaborative effort with Achray Photonics.

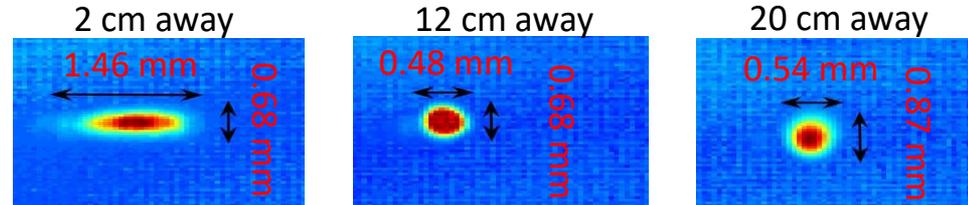
Highly divergent and asymmetric beam.

**Single-lens collimator delivers outstanding beam profile measured from lensed package at Herriott cell entrance to the far mirror!**

## Laser far-field emission profile **before** packaging

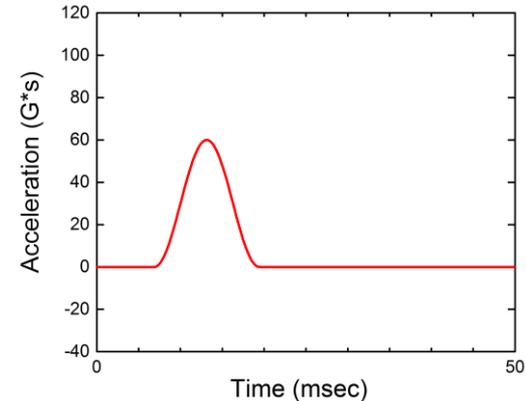
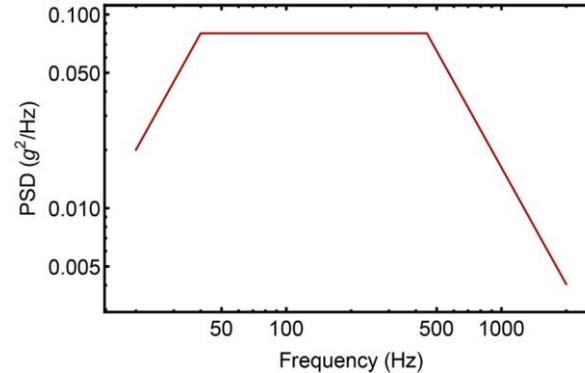


## Laser far-field emission profile **after** packaging

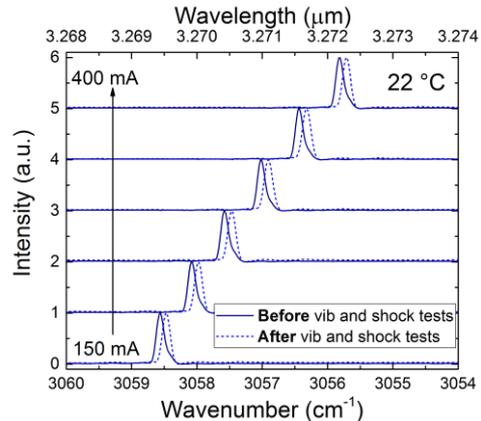
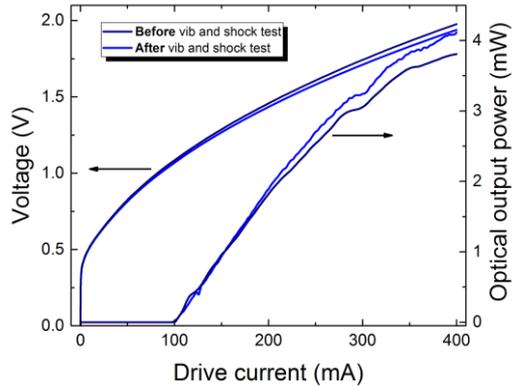


# Performance – Vib and shock testing

- Thermal Cycling
  - -40 °C to +80 °C, 8 cycles
- Leak Testing
  - Leak rate of  $1.5 \times 10^{-8}$  cc He/s after thermal cycling
- Random vibration based on TLS requirements
  - 20 to 40 Hz, +6 dB/octave
  - 40 to 450 Hz,  $0.08 \text{ g}^2/\text{Hz}$
  - 450 to 2000 Hz, -6 dB/octave
- Shock loading to 60 g
  - 60 g, 10 ms, half-sine pulse
  - 3 tests per direction, 2 directions per axis
  - 18 shock loads total

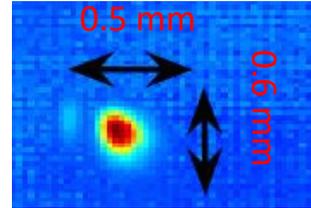


# Performance – Vib and shock testing of 3.27 $\mu\text{m}$ laser

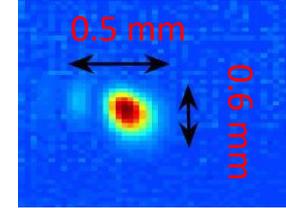


Optical beam 12 cm away from the laser package

Before environmental testing



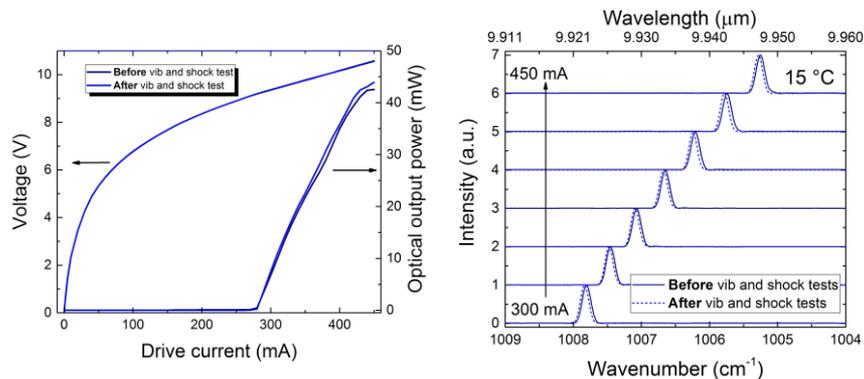
After environmental testing



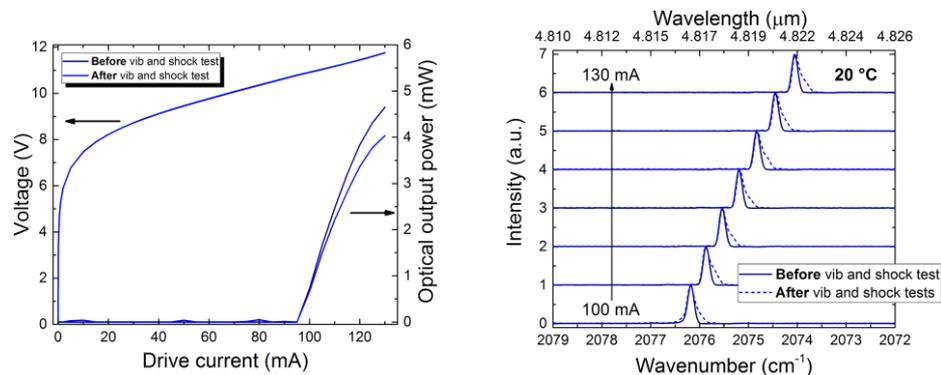
- Current threshold, voltage, and output power do not change with environmental testing
- Emitted wavelength as a function of drive current remained constant
- Optical beam wasn't affected by the environmental testing meaning the lens mounting scheme isn't affected by typical environmental conditions

# Intersubband cascade lasers up to 10 $\mu\text{m}$

## 9.92 $\mu\text{m}$ laser

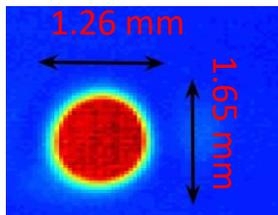


## 4.82 $\mu\text{m}$ laser

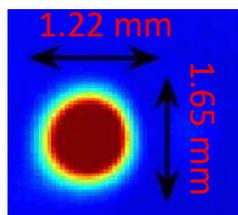


Optical beam 12 cm away from the laser package

Before environmental testing



After environmental testing



We developed semiconductor laser sources up to a wavelength of 10  $\mu\text{m}$  that are suitable for space applications

# Conclusion

- We have fabricated and tested reliable lasers at 2.65  $\mu\text{m}$ , 3.27  $\mu\text{m}$ , and 3.57  $\mu\text{m}$
- We have developed and tested 3.27  $\mu\text{m}$  semiconductor lasers that are suitable for space applications
- We have developed semiconductor lasers for space applications that covers a wide mid-IR wavelength range

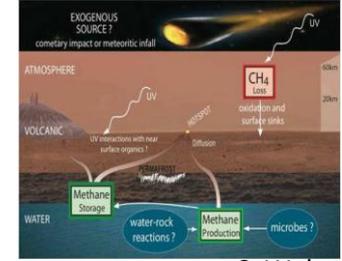
# Future work

- Space qualification of IC lasers
- Lifetime measurements of lasers
- Development of Venus and Saturn probes
- Development of gas sensors for the ISS and Orion
- Development of novel gas sensors for Earth and climate sciences

1/29/2018

SPIE Photonics West

## Planetary structure and evolution



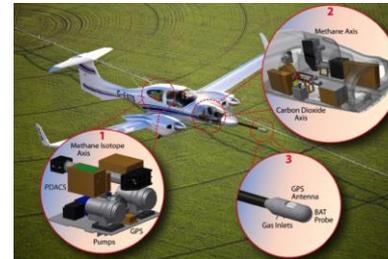
C. Webster, JPL

## Human spaceflight operations



NASA

## Earth and climate sciences



J. Anderson, Harvard Univ.



Liz Moyer, Univ. Chicago

jpl.nasa.gov

# Acknowledgement

- **Dr. James Gupta** and his group at the National Research Council of Canada
  - **Design and growth of GaSb-based diode lasers**
- **Dr. Jerry Meyer** and his group at the Naval Research Laboratory
  - **Design and growth of GaSb-based interband cascade lasers**
- JPL's Advanced Microfabrication and Optoelectronics group
  - **Ryan M. Briggs, Clifford Frez, Mahmood Bagheri, and Siamak Forouhar**
- The research was carried out at the Jet Propulsion Laboratory, California Institute of Technology, under a contract with the National Aeronautics and Space Administration



**Jet Propulsion Laboratory**  
California Institute of Technology

---

[jpl.nasa.gov](https://jpl.nasa.gov)